Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/517,446	UENO ET AL.	
Examiner	Art Unit	
Andrew B Freistein	1626	

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Class	Subclass	Date	Examiner
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Class	Subclass	Date	Examiner	
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	DATE	EXMR
Restriction	5/16/2006	ABF
STN (see attached)	7/8/2006	ABF
Inventor Name	7/8/2006	ABF